

<b>Notice of References Cited</b>		Application/Control No. 10/581,194	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner PHUTTHIWAT WONGWIAN	Art Unit 3741	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0204745	09-2005	Hirayama et al.	060/773
*	B	US-6,782,691	08-2004	Nagata et al.	60/39.091
*	C	US-6,868,663	03-2005	Nagata et al.	60/39.091
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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